Se	arch	Note	es

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/525,931	UENISHI ET AL.	
Examiner	Art Unit	
Tung S. Lau	2863	

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Class	Subclass	Date	Examiner
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702	[0]		
177	25011		
700	305		
702	113		1

INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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